STF40N65M2



N-channel 650 V, 0.087 Ω typ., 32 A MDmesh™ M2 Power MOSFET in a TO-220FP package

Datasheet - production data

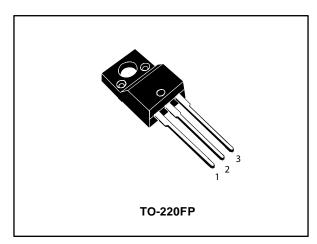
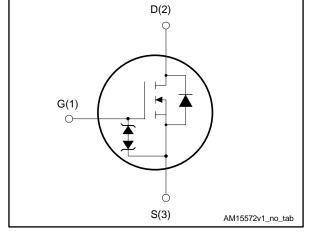


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D
STF40N65M2	650 V	0.099 Ω	32 A

- Extremely low gate charge
- Excellent output capacitance (C_{OSS}) profile
- 100% avalanche tested
- Zener-protected

Applications

Switching applications

Description

This device is an N-channel Power MOSFET developed using MDmesh™ M2 technology. Thanks to its strip layout and an improved vertical structure, the device exhibits low on-resistance and optimized switching characteristics, rendering it suitable for the most demanding high efficiency converters.

Table 1: Device summary

Order code	Marking	Package	Packaging
STF40N65M2	40N65M2	TO-220FP	Tube

February 2015 DocID027442 Rev 1 1/13

Contents STF40N65M2

Contents

1	Electric	eal ratings	3
2	Electric	al characteristics	4
	2.2	Electrical characteristics (curves)	6
3	Test cir	cuits	8
4	Package	e information	9
	_	TO-220FP package information	
5	Revisio	n history	12



STF40N65M2 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate-source voltage	± 25	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	32	Α
I _D ⁽¹⁾	Drain current (continuous) at T _C = 100 °C	20	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	128	А
P _{TOT}	Total dissipation at T _C = 25 °C	25	W
dv/dt (3)	Peak diode recovery voltage slope	15	V/ns
dv/dt (4)	MOSFET dv/dt ruggedness	50	V/ns
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; $T_C = 25$ °C)	2500	V
T _{stg}	Storage temperature	- 55 to 150	°C
T _j	Max. operating junction temperature	150	

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	3.13	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.50	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetetive or not repetetive (pulse width limited by T_{jmax})	3	Α
E _{AS}	Single pulse avalanche energy (starting T_j = 25 °C, I_D = I_{AR} , V_{DD} = 50 V)	820	mJ

⁽¹⁾Limited by maximum junction temperature.

 $[\]ensuremath{^{(2)}}\mbox{Pulse}$ width limited by safe operating area.

 $^{^{(3)}}$ $I_{SD} \le 32$ A, di/dt ≤ 400 A/µs; $V_{DS~peak} < V_{(BR)DSS}, \, V_{DD} = 400$ V

⁽⁴⁾ V_{DS} ≤ 520 V

2 Electrical characteristics

(T_C= 25 °C unless otherwise specified)

Table 5: On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	650			V
	Zero gate voltage Drain	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}$			1	μΑ
I _{DSS}	current	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V},$ $T_C = 125 \text{ °C}$			100	μΑ
I _{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 16 A		0.087	0.099	Ω

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	2355	ı	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	102	ı	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0 V$	-	2.7	-	pF
Coss eq. (1)	Equivalent output capacitance	$V_{DS} = 0 \text{ V to } 520 \text{ V}, V_{GS} = 0 \text{ V}$	-	380	-	pF
R_{G}	Intrinsic gate resistance	f = 1 MHz open drain	-	4.5	-	Ω
Q_g	Total gate charge	$V_{DD} = 520 \text{ V}, I_D = 32 \text{ A},$	-	56.5	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V (see <i>Figure 15:</i>	-	8	-	nC
Q_{gd}	Gate-drain charge	"Gate charge test circuit")	-	24	-	nC

Notes:



 $^{^{(1)}}C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 325 \text{ V}, I_D = 16 \text{ A}$	-	15	-	ns
t _r	Rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$ (see Figure 14: "Switching times	-	10	1	ns
t _{d(off)}	Turn-off-delay time	test circuit for resistive load"	-	96.5	-	ns
t _f	Fall time	and Figure 19: "Switching time waveform")	-	12	-	ns

Table 8: Source drain diode

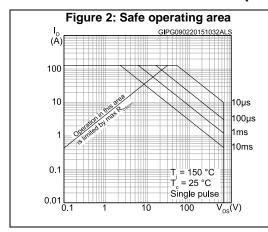
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		32	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		128	Α
V _{SD} ⁽²⁾	Forward on voltage	$V_{GS} = 0 \text{ V}, I_{SD} = 32 \text{ A}$	-		1.6	V
t _{rr}	Reverse recovery time	$I_{SD} = 32 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	468		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V (see Figure 16: " Test circuit for inductive load	-	8.7		μC
I _{RRM}	Reverse recovery current	switching and diode recovery times")	-	37.5		Α
t _{rr}	Reverse recovery time	$I_{SD} = 32 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	610		ns
Qrr	Reverse recovery charge	V_{DD} = 60 V, T_j = 150 °C (see Figure 16: " Test circuit for	-	11.7		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	39		Α

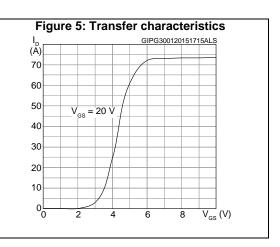
Notes:

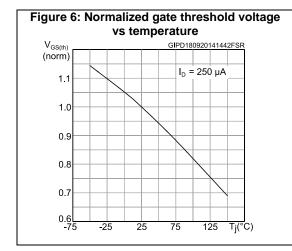
⁽¹⁾Pulse width is limited by safe operating area

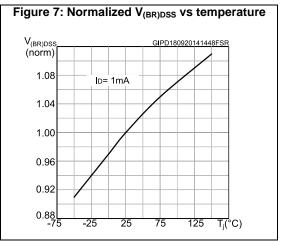
 $^{^{(2)}}$ Pulse test: pulse duration = 300 μ s, duty cycle 1.5%

2.2 Electrical characteristics (curves)









DocID027442 Rev 1

6/13

STF40N65M2 Electrical characteristics

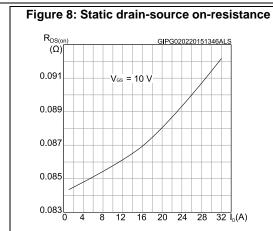


Figure 9: Normalized on-resistance vs. temperature

Rosion (norm)

2.2 Vos = 10 V

1.8

1.4

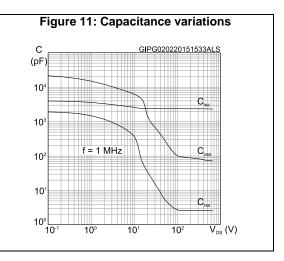
1.0

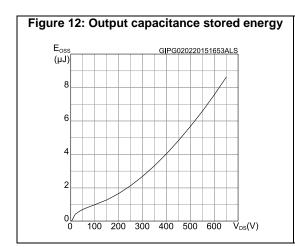
0.6

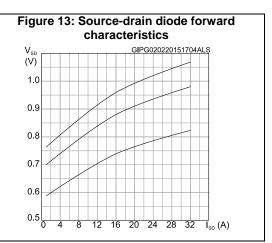
0.2

-75 -25 25 75 125 Tj(°C)

Figure 10: Gate charge vs. gate-source voltage GIPG020220151458ALS V_{DS} (V) (V)12 600 500 10 $V_{DD} = 520 \text{ V}$ $I_{D} = 32 \text{ A}$ 400 300 6 200 100 0 60 Qg(nC) 20 30 40

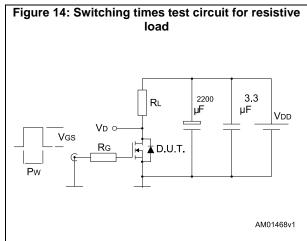


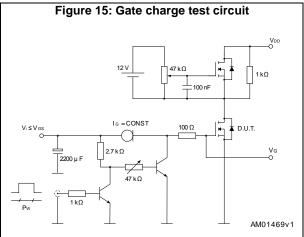


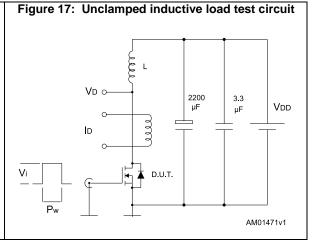


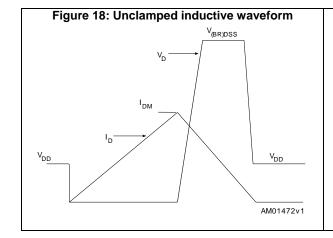
Test circuits STF40N65M2

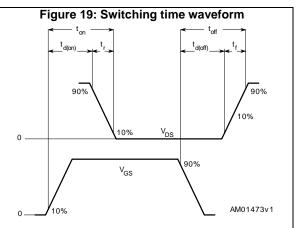
3 Test circuits











57

8/13

4 Package information

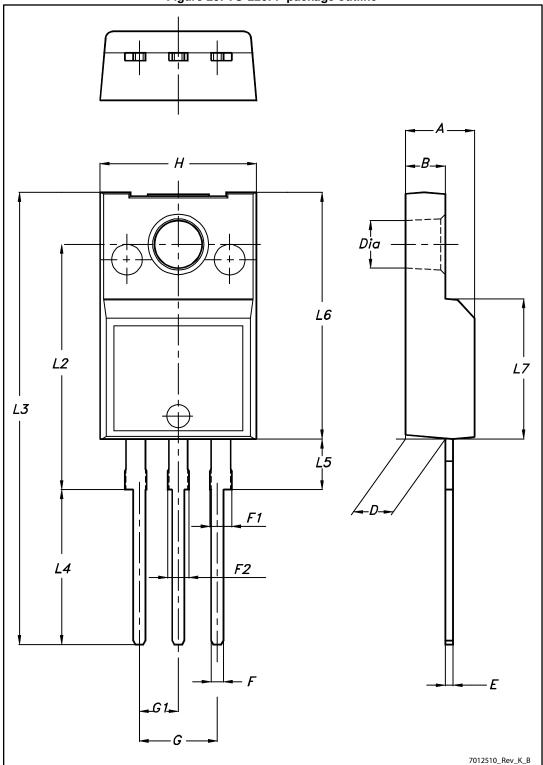
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.



DocID027442 Rev 1 9/13

4.1 TO-220FP package information

Figure 20: TO-220FP package outline



577

Table 9: TO-220FP mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
A	4.4		4.6
В	2.5		2.7
D	2.5		2.75
Е	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

Revision history STF40N65M2

5 Revision history

Table 10: Document revision history

Date	Revision	Changes
09-Feb-2014	1	First release.

IMPORTANT NOTICE - PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2015 STMicroelectronics - All rights reserved

